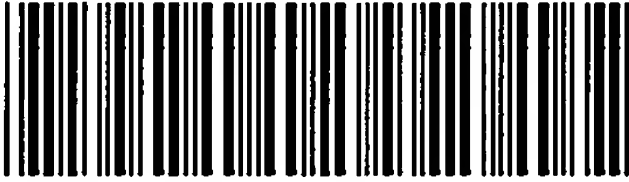


<b>Search Notes</b> 	<b>Application/Control No.</b>	<b>Applicant(s)/Patent under Reexamination</b>	
	10/663,136	LIU, FRANK	
	<b>Examiner</b>	<b>Art Unit</b>	
	Jia W. Lu	2611	

SEARCHED			
Class	Subclass	Date	Examiner
375	295	12/1/2006	JL
375	296	12/1/2006	JL

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
375	295	12/1/2006	JL

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
all east databses	12/1/2006	JL
inventorship	12/1/2006	JL